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APL	AA1	5,427,		06/27/1995	CARNEY et al.	-			 	=			
APL	AB1	6,063,		05/16/2000	LEUNG	-							
APC	AC1	5,058,		10/15/1991	SKEIRIK	-			+				
PARC	AD1	6,143,	092	11/07/2000	STRAUB et al.				+				
APL	AE1	6,071,		06/06/2000	OLSEN		ر		+	1			
APC	AF1	6,038,		03/14/2000	SAITOH et al.	7-			+				
APL	AG1	6,004,		12/21/1999	KUBIAK et al.	1							
ADL	AH1	5,891,		04/06/1999	STREETS et al.	1							
APL	Al1	5,680,		10/28/1997	EDSTRAND et al.	 							
APU	AJ1	5,405,		04/11/1995	ANDERSON et al.								
API	AK1	5,157,		10/20/1992	LOVRENICH	Τ-							
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APC	AR	AR 1 Kasko et al., "Integrated process control for cluster tools using an in-line analytical module", 1997 IEEE Int. Symp. Semiconductor Manufacturing, 1997, pp. P41-P44.											
APL	AS	1	Ober, O.N., *Au	Ober, O.N., *Automated pharmaceuticals manufacturing*, IEE Coll. Mechatronics, 1995, pp. 1/1-1/2.									
APL	Daubas, B. et al., "Combined simulation of hybrid processes", Humans, In and Technology, 1994 IEEE International Conference on Systems, Man, and Cybernetics, 2-5 October 1994, pp. 320-325.												
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<u> 201</u>	AA2	NUMBE 4,975,86		12/1990	Салеtte et al.	┼─		- T				
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	AC2	5,237,50		08/1993	Furukawa et al.	+=						
7 7 7 7	AD2	5,402,52		03/1995	Bauman et al.	1=	===					
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	AH2	5,343,38		08/1994	Honma et al.	+-		\rightarrow				
	Al2	5,408,40		04/1995	Mozumder et al.	₩						
	AJ2	5,440,47		08/1995	Fisher et al.	 - -						
APL	AK2	5,442,56	62	08/1995	Hopkins et al.	<u> </u>						
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APC	AR	2	Hwang, Y.K., et al., "Motion planning for robotic spray cleaning with environmentally safe solvents", Proc. 1993, IEEE/Tsukuba Int. Workshop on Advanced Robotics, 8-9 November 1993, pp. 49-54.									
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APC	AA3		5,463	3,555	10/1995	Ward et al.							
ALC	AB3		5,594	4,639	01/1997	Atsumi	1						
Apr	AC3		5,666	6,585	09/1997	Nagira et al.							
HAL	AD3		5,757	7,659	05/1998	Arai et al.							
ALL	AE3		5,969	9,973	10/1999	Boume et al.	_						
AVC	AF3		4,796	6,194	01/1989	Atherton	_						
AV	AG3		5,148	8,370	09/1992	Litt et al.	•	=					
APPL	AH3		5,164	4,905	11/1992	lwasaki et el.	_		/				
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APL	AA4	5,	,450,346	09/1995	Krummen et al.							
M	AB4	5,			Fuduka et al.							
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ARC	AD4	5,	,774,875	06/1998	Medeiros et al.	二						
APC	AE4	5,	,841,660	11/1998	Robinson et al.							
APL	AF4	6,	,311,095	10/2001	Brown	\vdash						
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APL	AR	4	Leitch et al., "A Real-Time Knowledge Based System for Product Quality Control," International Conference on Control, 1988, pp. 281-286.									
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APL	AT	4	Sam G. Taylor et al., APICS, Process Flow Scheduling: A Scheduling Systems Framework for Flow Manufacturing, Copyright 1994 (168 Pages).									
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APL	AR	<u>5</u>	Sam G. Taylor o	Sam G. Taylor et al., APICS, Can Process Flow Scheduling Help You?, pp. 44-46, March 1996.								
APL	AS	5	Copy of Internal	copy of International Search Report from PCT Appl. No. PCT/US00/22104, 2 pages, mailed January 25, 2001.								
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